


<b>Search Notes</b>  	<b>Application/Control No.</b>  10526410	<b>Applicant(s)/Patent Under Reexamination</b>  MIYATA, KAZUHIKO
	<b>Examiner</b>  HUYEN D LE	<b>Art Unit</b>  2614

SEARCHED			
Class	Subclass	Date	Examiner
381	152, 306, 333, 338, 388, 398, 431, 190	06/05/09	HL
361	681, 682, 683, 686	06/05/09	HL
181	171, 172	06/05/09	HL

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/HUYEN D LE/ Primary Examiner.Art Unit 2614
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